N-Channel 150 V (D-S) MOSFET

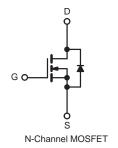
PRODUCT SUMMARY							
V _{DS} (V)	R _{DS(on)} (mΩ) (Typ.)	I _D (A) ^a	Q _g (Typ.)				
150	240 at V _{GS} = 10 V	10	13.2 nC				

FEATURES

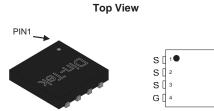
- DT-Trench Power MOSFET
- 100 % Rg and UIS tested
- · Fast Switching
- Low Gate Charge

APPLICATIONS

- DC-DC Converter
- · Power Management



PDFN3.3X3.3-8L Pin Configuration



ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage	V _{DS}	150	\/			
Gate-Source Voltage	V_{GS}	± 20	V			
Continuous Drain Current (T _J = 150 °C) ^a	T _C = 25 °C		10	А		
	T _C = 100 °C	I _D	6.3			
Pulsed Drain Current ^b	I _{DM}	40				
Single Avalanche Energy	E _{AS}	28.8	mJ			
Maximum Dawar Dissination (T _C = 25 °C	В	30	W		
Maximum Power Dissipation ^c	T _C = 100 °C	P _D	12]		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to +150	°C			

7 D

6 D

5 D

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	LIMIT	UNIT		
Junction-to-Ambient (PCB Mount) ^d	R _{thJA}	65	°C/W		
Junction-to-Case (Drain)	R _{thJC}	4.16	*C/VV		

- a. Calculated continuous current based on maximum allowablejunction temperature.
- b. Repetitive rating; pulse width limited by max. junction temperature.
- c. Pd is based on max. junction temperature, using junction-case thermal resistance.
- d. The value of R_{8JA} is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper,in a still air environment with Ta=25 °C.



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static				1111			
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	150	-	-		
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1.4	-	2.4	V	
Gate-Body Leakage	I _{GSS}			-	± 100	nA	
Zana Oata Valla va Busia Oamaat		V _{DS} = 150 V, V _{GS} = 0 V	-	-	1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 120 V, V _{GS} = 0 V, T _J = 100 °C	-	-	100	μΑ	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	10	-	-	Α	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 5 A	-	240	290	mΩ	
Forward Transconductance ^a	g_{fs} $V_{DS} = 5 \text{ V}, I_{D} = 5 \text{ A}$		-	18	-	S	
Dynamic ^b	_						
Input Capacitance	C _{iss}		-	425	-	pF	
Output Capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = 75 V, f = 1 MHz	-	17	-		
Reverse Transfer Capacitance	C _{rss}		-	11	-		
Total Gate Charge ^c	Q_g		-	13.2	-		
Gate-Source Charge ^c	Q _{gs}	V _{DS} = 75 V,V _{GS} = 10 V, I _D = 10 A	-	2.4	-	nC	
Gate-Drain Charge ^c	Q_{gd}		=	3.7	-		
Gate Resistance	R_g	f = 1 MHz	-	1.36	-	Ω	
Turn-On Delay Time ^c	t _{d(on)}		-	8.5	-		
Rise Time ^c	t _r	$V_{DD} = 75 \text{ V}, I_{D} = 1 \text{ A}, R_{g} = 5 \Omega$	-	10	-		
Turn-Off Delay Time ^c	t _{d(off)}	V _{GS} = 10 V	-	21	-	ns	
Fall Time ^c	t _f]	-	14.5	-	1	
Drain-Source Body Diode Ratings and	Characterist	ics ^b (T _C = 25 °C)		•			
Continuous Source-Drain Diode Current I _S T _C = 25 °C		T _C = 25 °C	-	-	10	Α	
Pulsed Current	I _{SM}		-	-	40	Α	
Forward Voltage ^a V_{SD} $I_F = 5 \text{ A}, V_{GS} = 0 \text{ V}$		-	-	1.2	V		

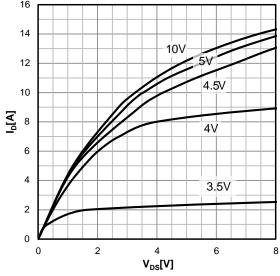
Notes

- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those in dicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended pe riods may affect device reliability.

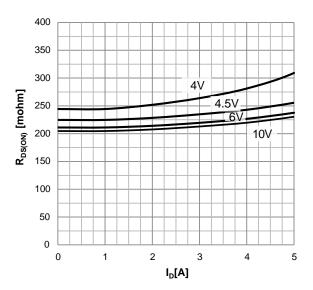


Figure 1: Typ. output characteristics



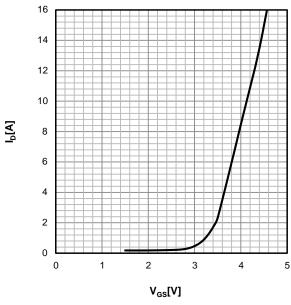
I_D=f(V_{DS}), T_i=25 °C; parameter: V_{GS}

Figure 2: Typ. drain-source on resistance



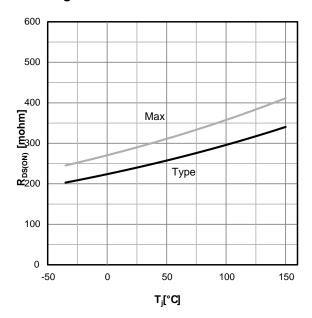
 $R_{DS(on)}=f(I_D)$, $T_j=25$ °C; parameter: V_{GS}

Figure 3: Typ. transfer characteristics



 $I_D \!\!=\!\! f(V_{GS}), \, |V_{DS}| \!\!>\!\! 2|I_D|R_{DS}(on)max;$

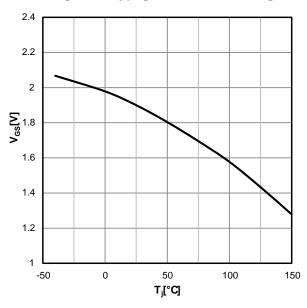
Figure 4: drain-source on resistance



 $R_{DS(on)} = f(T_j), I_D = 5.0A, V_{GS} = 10V;$

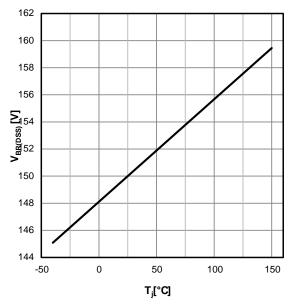






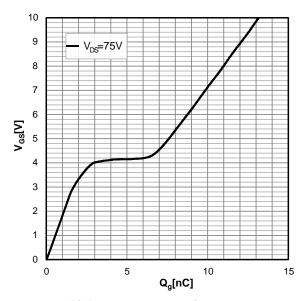
 $V_{GS}=f(T_i),I \ V_{GS}=V_{DS},I_D=250\mu A;$

Figure 6: Drain-source breakdown voltage



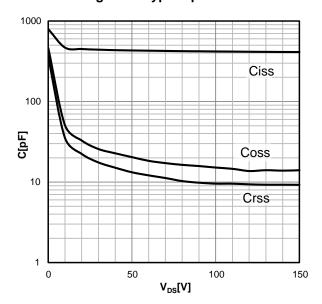
 $V_{BR(DSS)}=f(T_j); I_D=250\mu A;$

Figure 7: Typ. gate charge



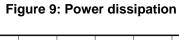
 V_{GS} =f(Q_g), I_D=10A, T_i=25 °C; parameter: V_{DS}

Figure 8: Typ. Capacitances



C= $f(V_{DS})$; $V_{GS}=0V$; f=1.0 MHz;





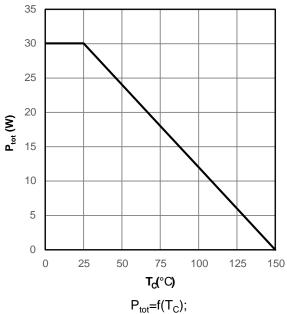


Figure 10:Drain current

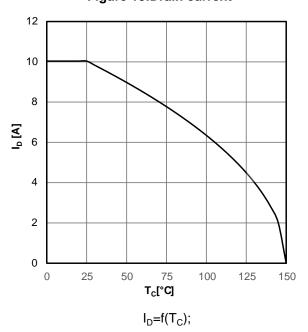
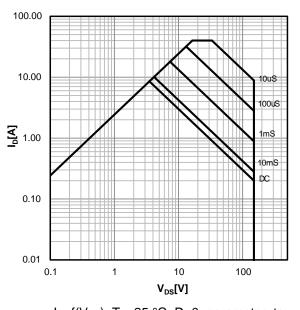
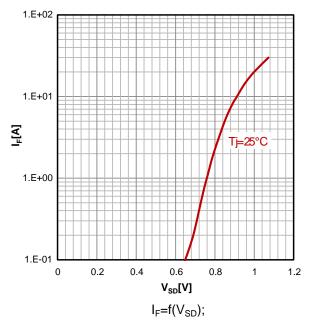


Figure 11: Safe operating area



 $I_D=f(V_{DS}); T_C=25$ °C; D=0; parameter: tp

Figure 12: Typ. forward characteristics





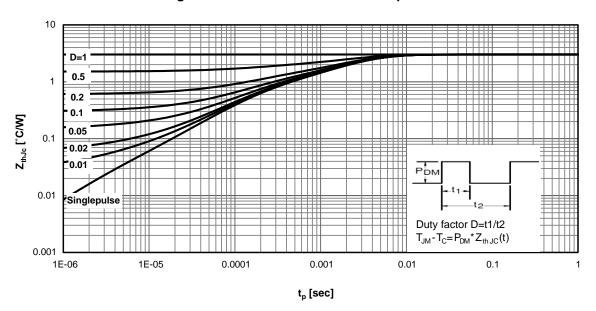
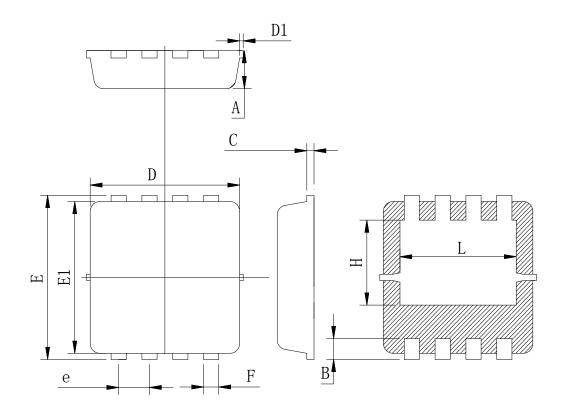


Figure 13: Max. Transient Thermal Impedance

 $Z_{thJC}=f(t_p)$; parameter: D

Din-Tek SEMICONDUCTOR

PDFN 3.3X3.3 PACKAGE OUTLINE



COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

Symbol	Min	Тур	Max
Α	0.600	0.775	1.000
В	0.20	0.38	0.55
С	0.05	0.15	0.40
D	3.10	3.25	3.50
D1	-	-	0.15
Е	3.15	3.35	3.50
E1	2.60	3.10	3.45
е	0.50	0.65	0.80
F	0.15	0.32	0.45
Н	1.25	1.73	2.10
L	2.20	2.45	2.85

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